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Form PTO 1449 (Modified)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO.		SERIAL NO.			
(madred)			264240US2PCT	10/522,185					
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- -	AO	2000 313962	11/14/00	JP (with English abstract)			NO		
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	AZ				Additional References/sheet(s) attached				
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		at appointment Include	conv of this for	n with next communication to applicant					